

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination NINOMIYA ET AL.	
		Examiner Phuong Phu	Art Unit 2631	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,307,598	10-2001	Limberg, Allen LeRoy	348/729
	B	US-6,353,463	03-2002	Seo, Young-Joo	348/731
	C	US-6,483,553	11-2002	Jung, Gwon Sool	348/731
	D	US-6,519,298	02-2003	Kim, Ki-bum	375/343
	E	US-6,108,044	08-2000	Shin, Hyun-soo	348/555
	F	US-6,757,025	06-2004	Takano et al.	348/554
	G	US-6,111,613	08-2000	Sasano et al.	348/468
	H	US-6,335,762	01-2002	Lee, Myeong-hwan	348/558
	I	US-6,046,781	04-2000	LeRoy, Allen	348/731
	J	US-5,982,457	11-1999	Limberg, Allen LeRoy	348/725
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.